Search Notes



Applicant(s)/Patent Under Application/Control No.

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Reexamination SONI ET AL.

Examiner

Art Unit

Flores, Leon

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SEARCHED

Class	Subclass	Date	Examiner		
375	355	2/15/2007	LF		
370	206, 338	2/15/2007	LF		

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of claim 1	2/20/2007	LF
Search in NPL (IEEE)	2/15/2007	LF
Checked for possible Double Patenting.	2/15/2007	LF
Consulted with SPE David Payne in regards to the amendments.	9/7/2007	LF
Consulted with SPE David Payne in regards to the amendments.	12/11/2007	LF
Consulted with SPE Shuwang Liu in regards to the RCE.	2/8/2008	LF
Consulted with SPE David Payne in regards to the RCE.	2/21/2008	LF
Consulted with SPE David Payne in regards to the amendments.	10/10/2008	LF

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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